



Modified Form PTO/SB/08A

<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b> (use as many sheets as necessary)				<i>Complete If Known</i>	
				Application Number	09/846,490
				Filing Date	April 30, 2001
				First Named Inventor	Eldridge et al.
				Group Art Unit	3729
				Examiner Name	C. Arbes
Sheet	1	of	2	Attorney Docket No.	P6D2-US

TECHNOLOGY CENTER R3729

JAN 24 2003

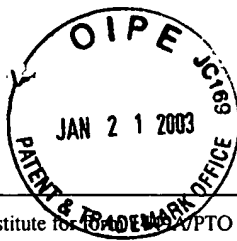
RECEIVED

U.S. PATENT DOCUMENTS						
Examiner Initials*	Cite No. <sup>1</sup>	U.S. Patent Document		Name of Patentee or Applicant	Publication Date	Relevant Portions
		Number	Kind Code <sup>2</sup>			
CJA	1	3810301		Cook	5/15/1974	
CJA	2	3835530		Kilby	9/17/1974	
CJA	3	4281449		Ports et al.	8/4/1981	
CJA	4	4623839		Garretson et al.	11/18/1986	
CJA	5	4795977		Frost et al.	1/3/1989	
CJA	6	4924589		Leedy	5/15/1990	
CJA	7	5055780		Takagi et al.	10/8/1991	
CJA	8	5177438		Littlebury et al.	1/5/1993	
CJA	9	5412329		Iino et al.	5/2/1995	
CJA	10	5465611		Ruf et al.	11/14/1995	
CJA	11	5476818		Yanof et al.	12/19/1995	
CJA	12	5666190		Quate et al.	9/9/1997	
CJA	13	5720098		Kister	2/24/1998	
CJA	14	5811982		Beaman et al.	9/22/1998	
CJA	15	6032356		Eldridge et al.	3/7/2000	
CJA	16	6215320	B1	Parrish	4/10/2001	
CJA	17	6219908	B1	Farnworth et al.	4/24/2001	
CJA	18	6330164	B1	Khandros et al.	12/11/2001	
CJA	19	6334247	B1	Beaman et al.	1/1/2002	
CJA	20	6392426	B2	Farnsworth et al.	5/21/2002	

Examiner Signature	Cy Arbes	Date Considered	2/1/03
-----------------------	----------	--------------------	--------

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication

<sup>1</sup>Unique citation designation number. <sup>2</sup>See attached Kinds of U.S. Patent Documents. <sup>3</sup>Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). <sup>4</sup>For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. <sup>5</sup>Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. <sup>6</sup>Applicant is to place a check mark here if English language Translation is attached.



Modified Form PTO/SB/08A

<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b> (use as many sheets as necessary)				<i>Complete If Known</i>	
				Application Number	09/846,490
				Filing Date	April 30, 2001
				First Named Inventor	Eldridge et al.
				Group Art Unit	3729
				Examiner Name	C. Arbes
Sheet	2	of	2	Attorney Docket No.	P6D2-US

TECHNOLOGY CENTER R3700

RECEIVED  
JAN 24 2003

FOREIGN PATENT DOCUMENTS						
Examiner Initials <sup>*</sup>	Cite No. <sup>1</sup>	Foreign Patent Document			Name of Patentee or Applicant	Publication Date
		Office <sup>2</sup>	Number <sup>4</sup>	Kind Code <sup>5</sup>		
Cja	21	EP	544305	A2	Ouchi et al.	6/2/1993
Cja	22	JP	04-93157		Tazawa	8/13/1992
Cja	23	JP	05-018741		Kawase et al.	1/26/1993
Cja	24	JP	05-198716		Osawa	8/6/1993
Cja	25	JP	06-267408		Todokoro et al.	9/22/1994
Cja	26	JP	07-021968		Watanabe et al.	1/24/1995
Cja	27	JP	07-333232		Tagi et al.	12/22/1995
Cja	28	JP	59-088860		Hatada et al.	5/22/1984
Cja	29	JP	62-160373		Mizumo et al.	10/12/1987

OTHER PRIOR ART - NONPATENT LITERATURE DOCUMENTS			
Examiner Initials <sup>*</sup>	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	T <sup>2</sup>
Cja	31	KONG et al., "Integrated electrostatically resonant scan tip for an atomic force microscope," J. Vac. Sci. Technol. B 11(3) (May/June 1993), pp. 634-645	
Cja	32	LEUNG et al., "Active Substrate Membrane Probe Card," Center for Integrated Systems, Stanford University, October 12, 1995, pp. 29.2.1-29.2.4	

Examiner Signature	C. J. Arbes	Date Considered	2/1/03
-----------------------	-------------	--------------------	--------

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication

<sup>1</sup>Unique citation designation number. <sup>2</sup>See attached Kinds of U.S. Patent Documents. <sup>3</sup>Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). <sup>4</sup>For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. <sup>5</sup>Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. <sup>6</sup>Applicant is to place a check mark here if English language Translation is attached.